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FDC6420C

20V N & P-Channel PowerTrench® MOSFETs

General Description

These N & P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

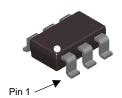
These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive SO-8 and TSSOP-8 packages are impractical.

Applications

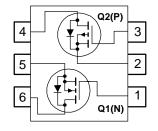
- DC/DC converter
- Load switch
- · LCD display inverter

Features

- Q1 3.0 A, 20V. $R_{DS(ON)} = 70~m\Omega @V_{GS} = 4.5~V$ $R_{DS(ON)} = 95~m\Omega @V_{GS} = 2.5~V$
- Q2 –2.2 A, 20V. $R_{DS(ON)} = 125 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 190 \text{ m}\Omega$ @ $V_{GS} = -2.5 \text{ V}$
- · Low gate charge
- High performance trench technology for extremely low $R_{\text{DS(ON)}}$.
- SuperSOT –6 package: small footprint (72% smaller than SO-8); low profile (1mm thick).



SuperSOT™-6



Absolute Maximum Ratings T _{A=25°C} un	nless otherwise noted
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Symbol	Parameter		Q1	Q2	Units
V _{DSS}	Drain-Source Voltage		20	-20	V
V _{GSS}	Gate-Source Voltage		±12	±12	V
I _D	Drain Current - Continuous	(Note 1a)	3.0	-2.2	Α
	– Pulsed		12	-6	
P _D	Power Dissipation for Single Operation	(Note 1a)	0.0	96	
		(Note 1b)	0.	9	W
		(Note 1c)	0.	7	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		–55 to	+150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	130	°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	60	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.420	FDC6420C	7"	8mm	3000 units

Symbol	I Parameter		Test Conditions		Min	Тур	Max	Units	
Off Char	acteristics								
BV _{DSS}	Drain-Source Breakdown Volta	ge	$V_{GS} = 0 \text{ V}, \qquad I_D = 250 \mu\text{A} \ V_{GS} = 0 \text{ V}, \qquad I_D = -250 \mu\text{A}$	Q1 Q2	20 –20			V	
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperatur	re	$I_D = 250 \mu A$, Ref. to 25°C $I_D = -250 \mu A$, Ref. to 25°C	Q1 Q2		13 –11		mV/°C	
I _{DSS}	Zero Gate Voltage Drain Currer	nt	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	Q1 Q2			1 -1	μΑ	
I _{GSSF}	Gate-Body Leakage, Forward		$V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V} $ $V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$	Q1 Q2			100 100	nA	
I _{GSSR}	Gate-Body Leakage, Reverse		$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$	Q1 Q2			-100 -100	nA	
On Char	acteristics (Note 2)								
$V_{GS(th)}$	Gate Threshold Voltage	Q1	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		0.5	0.9	1.5	V	
		Q2	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$		-0.6	-1.0	-1.5		
$\Delta V_{GS(th)}$	Gate Threshold Voltage	Q1	I _D = 250 μA, Ref. To 25°C			-3		mV/°C	
ΔT_{J}	Temperature Coefficient	Q2	$I_D = -250 \mu\text{A}$, Ref. to 25°C			-3			
R _{DS(on)}	Static Drain–Source	Q1	$V_{GS} = 4.5 \text{ V}, I_D = 3.0 \text{ A}$			50	70	mΩ	
D3(011)	On–Resistance		$V_{GS} = 2.5 \text{ V}, I_D = 2.5 \text{ A}$			66	95		
			$V_{GS} = 4.5 \text{ V}, I_D = 3.0 \text{ A}, T_J = 12$	25°C		71	106		
		Q2	$V_{GS} = -4.5 \text{ V}, I_D = -2.2 \text{ A}$			100	125		
			$V_{GS} = -2.5 \text{ V}, I_D = -1.8 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -2.2 \text{ A}, T_J = 1$	25°C		145 137	190 184		
I _{D(on)} On–State Drain Current		Q1	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$		12	137	101	Α	
Totale Brain Surren	On State Brain Surrent	Q2	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$		-6				
a Forward Trans	Forward Transconductance	Q1	$V_{DS} = 5 \text{ V}$ $I_{D} = 2.5 \text{ A}$		_0	10		S	
g _{FS} Forward Transconductance		Q2	$V_{DS} = -5 \text{ V}$ $I_D = -2.0 \text{A}$			6			
Dynamic	Characteristics	42	50 - 5 -						
	Input Capacitance	Q1	V _{DS} =10 V, V _{GS} = 0 V, f=1.0M	IH ₇		324		nE	
C_{iss}	Input Capacitance	Q2	$V_{DS}=10 \text{ V}, \text{ V}_{GS}=0 \text{ V}, \text{ I=1.0}\text{ V}$ $V_{DS}=-10 \text{ V}, \text{ V}_{GS}=0 \text{ V}, \text{ f=1.0}\text{ I}$			337		pF	
<u> </u>	Output Conscitones		$V_{DS}=10 \text{ V}, \text{ V}_{GS}=0 \text{ V}, \text{ I}=1.00 \text{ V}$					"F	
Coss	Output Capacitance	Q1	$V_{DS}=10 \text{ V}, V_{GS}=0 \text{ V}, I=1.000$ $V_{DS}=-10 \text{ V}, V_{GS}=0 \text{ V}, f=1.00$			82		pF	
	December Transfer Committee	Q2	20 7 00 7			88			
C_{rss}	Reverse Transfer Capacitance	Q1	$V_{DS}=10 \text{ V}, V_{GS}=0 \text{ V}, f=1.0 \text{M}$			42		pF	
		Q2	V_{DS} =-10 V, V $_{GS}$ = 0 V, f=1.01	VIHZ		51			
Switchin	g Characteristics (Note 2)	1	1		ı	1	Т		
$t_{d(on)}$	Turn-On Delay Time	Q1	For Q1 :			5	10	ns	
		Q2	$V_{DS} = 10 \text{ V}, I_{DS} = 1 \text{ A}$			9	18		
t _r	Turn-On Rise Time	Q1	V_{GS} = 4.5 V, R_{GEN} = 6 Ω			7	14	ns	
	T 0"D T	Q2	For Q2 : V _{DS} =–10 V, I _{DS} = –1 A			12	22		
$t_{d(off)}$	Turn-Off Delay Time	Q1	$V_{DS} = -10 \text{ V}, I_{DS} = -1 \text{ A}$ $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$			13	23	ns	
	Turn Off Fall Time	Q2	J. J			10	20 3	,	
t _f	Turn–Off Fall Time	Q1 Q2	-			1.6 5	10	ns	
0	Total Gate Chargo	Q1	F 04			3.3	4.6	r.C	
Q_g	Total Gate Charge	Q2	For Q1 : V _{DS} = 10 V, I _{DS} = 3.0 A			3.7	7.0	nC	
Q _{gs}	Gate-Source Charge	Q1	$V_{GS} = 4.5 \text{ V},$			0.95		nC	
~ys	Jako Joan do Oriango	Q2	For Q2 :			0.68			
Q _{gd}	Gate-Drain Charge	Q1	$V_{DS} = -10 \text{ V}, I_{DS} = -2.2 \text{ A}$ $V_{GS} = -4.5 \text{ V},$			0.7		nC	
gu		Q2	v _{GS} = -4.5 v,			1.3			

Electrical Characteristics

T_A = 25°C unless otherwise noted

Symbol	Parameter Test Condition		ns	Min	Тур	Max	Units	
Drain-Se	Drain-Source Diode Characteristics and Maximum Ratings							
Is	Maximum Continuous Drain—Source Diode Forward Current			Q1			0.8	Α
							-0.8	
V _{SD}	Drain-Source Diode Forward	$V_{GS} = 0 \text{ V}, I_{S} = 0.8 \text{ A}$	(Note 2)		0.7	1.2	V	
Voltage		Q2	$V_{GS} = 0 \text{ V}, I_{S} = 0.8 \text{ A}$	(Note 2)		-0.8	-1.2	

Notes:

 R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{9CA} is determined by the user's board design.



a) 130 °C/W when mounted on a 0.125 in² pad of 2 oz. copper.



b) 140 °C/W when mounted on a .004 in² pad of 2 oz copper



c) 180 C°/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

Typical Characteristics: N-Channel

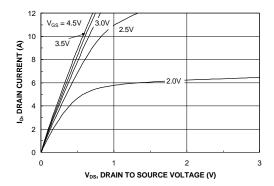


Figure 1. On-Region Characteristics.

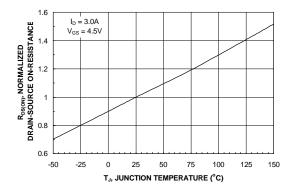


Figure 3. On-Resistance Variation with Temperature.

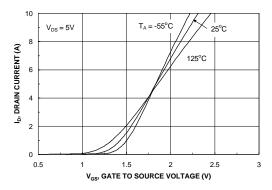


Figure 5. Transfer Characteristics.

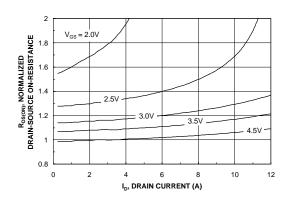


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

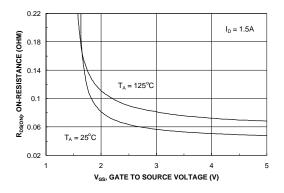


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

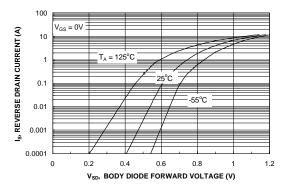
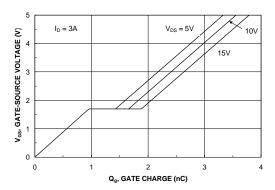


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



450
360
360
C_{ISS}
0
0
5
10
15
20
V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

Figure 7. Gate Charge Characteristics.

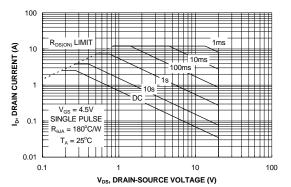


Figure 8. Capacitance Characteristics.

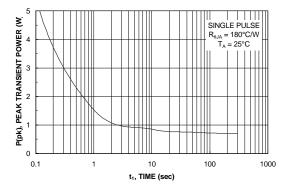
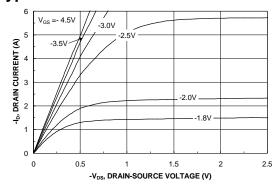


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

Typical Characteristics: P-Channel



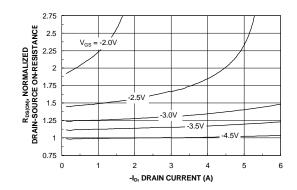
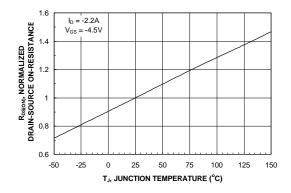


Figure 11. On-Region Characteristics.

Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.



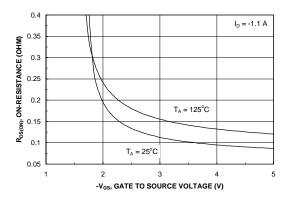
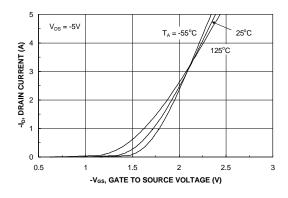


Figure 13. On-Resistance Variation with Temperature.

Figure 14. On-Resistance Variation with Gate-to-Source Voltage.



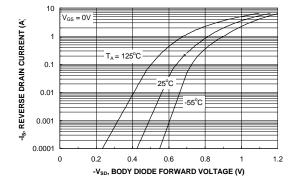
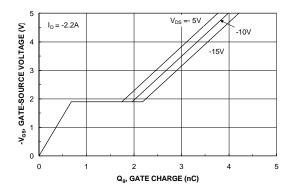


Figure 15. Transfer Characteristics.

Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



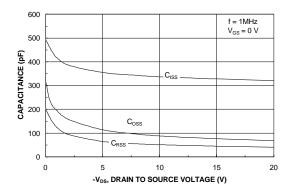
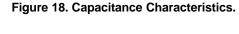
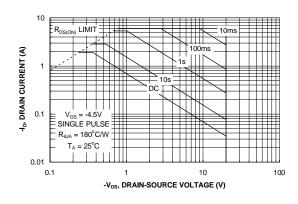


Figure 17. Gate Charge Characteristics.





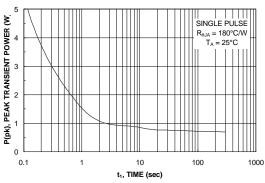


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

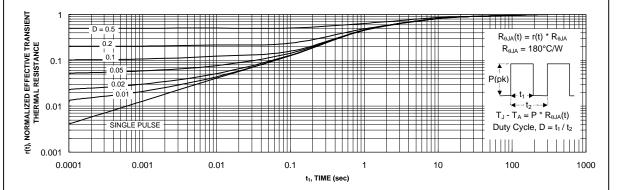


Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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